Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10590966	FUNAHASHI ET AL.	
Examiner	Art Unit	
HUYEN D LE	2615	

SEARCHED					
Class	Subclass	Date	Examiner		
381	396, 398, 403, 404, 405, 407, 423-425, 431-433	8/26/08	HL		
181	171-173, 163-165	8/26/08	HL		

SEARCH NOTES				
Search Notes	Date	Examiner		

INTERFERENCE SEARCH					
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